

MOS FIELD EFFECT TRANSISTOR μ PA1730

SWITCHING P-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

The μ PA1730 is P-Channel MOS Field Effect Transistor designed for power management applications of notebook computers and Li-ion battery protection circuit.

FEATURES

• Low on-resistance

RDS(on)1 = $9.5 \text{ m}\Omega$ MAX. (VGS = -10 V, ID = -6.5 A)

 $R_{DS(on)2} = 13.5 \text{ m}\Omega \text{ MAX.}$ (Vgs = -4.5 V, ID = -6.5 A)

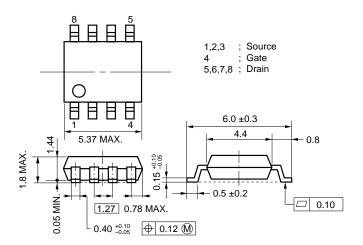
RDS(on)3 = 15.0 m Ω MAX. (VGS = -4.0 V, ID = -6.5 A)

- Low Ciss: Ciss = 3800 pF TYP.
- Built-in G-S protection diode
- Small and surface mount package (Power SOP8)

ORDERING INFORMATION

PART NUMBER	PACKAGE
μ PA1730G	Power SOP8

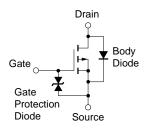
PACKAGE DRAWING (Unit: mm)



ABSOLUTE MAXIMUM RATINGS (T_A = 25°C, All terminals are connected.)

Drain to Source Voltage (Vgs = 0 V)	VDSS	-30	V
Gate to Source Voltage (Vps = 0 V)	Vgss	∓ 20	V
Drain Current (DC)	ID(DC)	∓ 13.0	Α
Drain Current (pulse) Note1	ID(pulse)	∓ 52.0	Α
Total Power Dissipation (T _A = 25°C) Note2	Рт	2.2	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	-55 to +150	°C

EQUIVALENT CIRCUIT



Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1 %

2. Mounted on ceramic substrate of 1200 mm² x 2.2 mm

Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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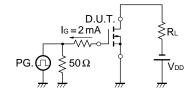
ELECTRICAL CHARACTERISTICS (TA = 25 °C, All terminals are connected.)

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain to Source On-state Resistance	RDS(on)1	V _{GS} = -10 V, I _D = -6.5 A		7.6	9.5	mΩ
	RDS(on)2	V _{GS} = -4.5 V, I _D = -6.5 A		10.3	13.5	mΩ
	RDS(on)3	V _{GS} = -4.0 V, I _D = -6.5 A		11.3	15.0	mΩ
Gate to Source Cut-off Voltage	VGS(off)	V _{DS} = -10 V, I _D = -1 mA	-1.0	-1.6	-2.5	V
Forward Transfer Admittance	yfs	V _{DS} = -10 V, I _D = -6.5 A	11.0	23.0		S
Drain Leakage Current	IDSS	V _{DS} = -30 V, V _{GS} = 0 V			-1	μΑ
Gate to Source Leakage Current	Igss	V _G s = ∓ 20 V, V _D s = 0 V			∓ 10	μΑ
Input Capacitance	Ciss	V _{DS} = −10 V		3800		pF
Output Capacitance	Coss	Vcs = 0 V		1200		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		500		pF
Turn-on Delay Time	td(on)	I _D = -6.5 A		40		ns
Rise Time	tr	VGS(on) = -10 V		240		ns
Turn-off Delay Time	td(off)	V _{DD} = -15 V		230		ns
Fall Time	tf	R _G = 10 Ω		160		ns
Total Gate Charge	QG	ID = -13.0 A		70		nC
Gate to Source Charge	Qgs	V _{DD} = -24 V		9		nC
Gate to Drain Charge	Q _{GD}	V _{GS} = −10 V		17		nC
Body Diode Forward Voltage	VF(S-D)	IF = 13 A, VGS = 0 V		0.80		V
Reverse Recovery Time	trr	IF = 13 A, Vgs = 0 V		53		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/ μs		57		nC

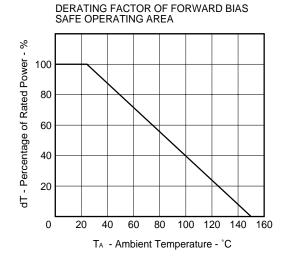
TEST CIRCUIT 1 SWITCHING TIME

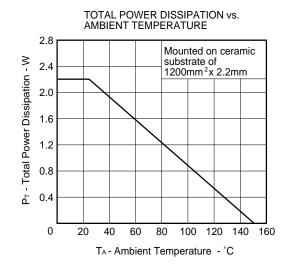
$PG. \bigcap_{RG} R_{G} = 10 \Omega$ V_{DD} V_{GS} $V_{Wave Form}$ V_{GS} V_{GS}

TEST CIRCUIT 2 GATE CHARGE

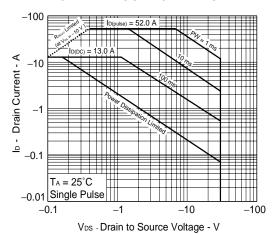


TYPICAL CHARACTERISTICS (TA = 25 °C)



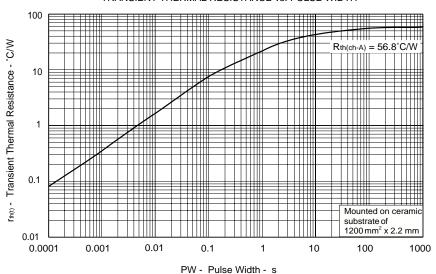


★ FORWARD BIAS SAFE OPERATING AREA

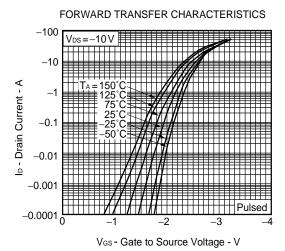


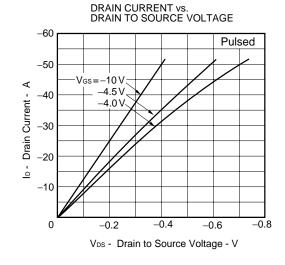
Remark Mounted on ceramic substrate of 1200 mm² x 2.2 mm

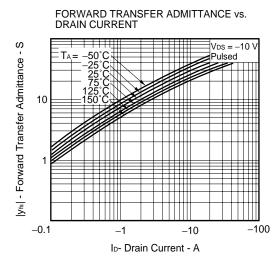
TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

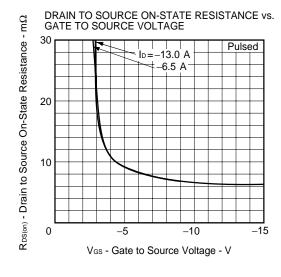


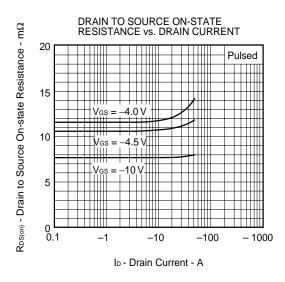
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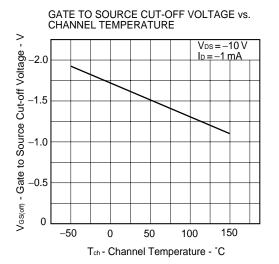


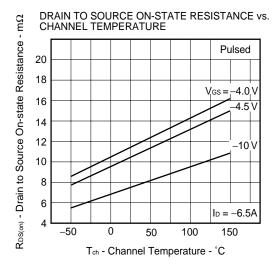


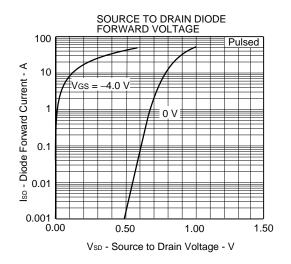


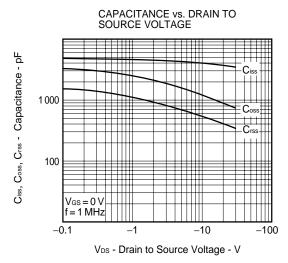


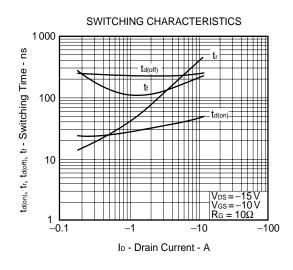


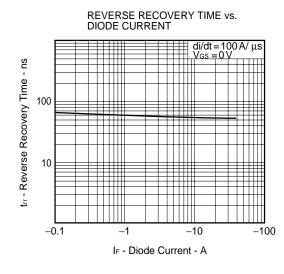


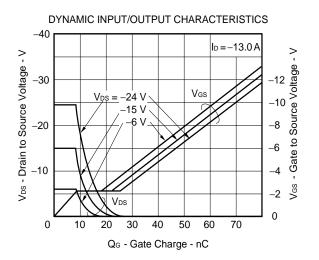












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NEC μ PA1730

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